

Search Notes

Application/Control No.

10/625,792

Examiner

Patrick J. Lee

Applicant(s)/Patent under
Reexamination

MANDRO ET AL.

Art Unit

2878

SEARCHED

Class	Subclass	Date	Examiner
250	221, 222.1, 231.1, 231.13	12/23/2005	PL
250	231.14	12/23/2005	PL
250	231.18	12/23/2005	PL
341	13, 141	12/23/2006	PL

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
East (See attached) - USPAT, US- PGPUB, EPO, JPO, DERWENT	12/23/2005	PL